## Notice of References Cited

Application/Control No. 09/526,391	Applicant(s)/Patent Under Reexamination YAMAO, HIDEKI	
Examiner	Art Unit	
BINH K. TIEU	2614	Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,643,781	11-2003	Merriam, Charles	726/35
*	В	US-7,047,426	05-2006	Andrews et al.	713/155
*	С	US-2004/0204021	10-2004	Cocita, Keith	455/550.1
*	D	US-2005/0186989	08-2005	Cocita, Keith	455/558
*	E	US-5,748,084	05-1998	Isikoff, Jeremy M.	340/568.1
*	F	US-6,304,969	10-2001	Wasserman et al.	713/172
*	G	US-5,987,609	11-1999	Hasebe, Mikio	726/35
*	Н	US-6,151,493	11-2000	Sasakura et al.	455/421
*	1	US-6,507,914	01-2003	Cain et al.	726/35
*	J	US-6,813,498	11-2004	Durga et al.	455/456.1
*	к	US-6,480,096	11-2002	Gutman et al.	340/5.31
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				,	
	0					
	Р					
	Q					7.244.10
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.